Intel - EP4CE55F23I8L Datasheet





Welcome to <u>E-XFL.COM</u>

Understanding <u>Embedded - FPGAs (Field</u> <u>Programmable Gate Array)</u>

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

Applications of Embedded - FPGAs

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

Details	
Product Status	Active
Number of LABs/CLBs	3491
Number of Logic Elements/Cells	55856
Total RAM Bits	2396160
Number of I/O	324
Number of Gates	-
Voltage - Supply	0.97V ~ 1.03V
Mounting Type	Surface Mount
Operating Temperature	-40°C ~ 100°C (TJ)
Package / Case	484-BGA
Supplier Device Package	484-FBGA (23x23)
Purchase URL	https://www.e-xfl.com/product-detail/intel/ep4ce55f23i8l

Email: info@E-XFL.COM

Address: Room A, 16/F, Full Win Commercial Centre, 573 Nathan Road, Mongkok, Hong Kong

Chapter Revision Dates

The chapters in this document, Cyclone IV Device Handbook,, were revised on the following dates. Where chapters or groups of chapters are available separately, part numbers are listed.

- Chapter 1. Cyclone IV FPGA Device Family Overview Revised: March 2016 Part Number: CYIV-51001-2.0
- Chapter 2. Logic Elements and Logic Array Blocks in Cyclone IV Devices Revised: *November* 2009 Part Number: *CYIV-51002-1.0*
- Chapter 3. Memory Blocks in Cyclone IV Devices Revised: *November* 2011 Part Number: *CYIV-51003-1.1*
- Chapter 4. Embedded Multipliers in Cyclone IV Devices Revised: *February* 2010 Part Number: *CYIV-51004-1.1*
- Chapter 5. Clock Networks and PLLs in Cyclone IV Devices Revised: October 2012 Part Number: CYIV-51005-2.4
- Chapter 6. I/O Features in Cyclone IV Devices Revised: March 2016 Part Number: CYIV-51006-2.7
- Chapter 7. External Memory Interfaces in Cyclone IV Devices Revised: March 2016 Part Number: CYIV-51007-2.6
- Chapter 8. Configuration and Remote System Upgrades in Cyclone IV Devices Revised: *May 2013* Part Number: *CYIV-51008-1.7*
- Chapter 9. SEU Mitigation in Cyclone IV Devices Revised: May 2013 Part Number: CYIV-51009-1.3
- Chapter 10. JTAG Boundary-Scan Testing for Cyclone IV Devices Revised: December 2013 Part Number: CYIV-51010-1.3
- Chapter 11. Power Requirements for Cyclone IV Devices Revised: May 2013 Part Number: CYIV-51011-1.3

In this mode, the activeclock signal mirrors the clkswitch signal. As both blocks are still functional during the manual switch, neither clkbad signals go high. Because the switchover circuit is positive edge-sensitive, the falling edge of the clkswitch signal does not cause the circuit to switch back from inclk1 to inclk0. When the clkswitch signal goes high again, the process repeats. The clkswitch signal and the automatic switch only works depending on the availability of the clock that is switched to. If the clock is unavailable, the state machine waits until the clock is available.



When CLKSWITCH = 1, it overrides the automatic switch-over function. As long as clkswitch signal is high, further switch-over action is blocked.

	•
inclk0	
inclk1 _	
muxout	
clkswitch _	
activeclock _	
clkbad0 —	
clkbad1 —	

Figure 5–19. Clock Switchover Using the clkswitch Control (1)

Note to Figure 5–19:

(1) Both inclk0 and inclk1 must be running when the clkswitch signal goes high to start a manual clock switchover event.

Manual Clock Switchover

PLLs of Cyclone IV devices support manual switchover, in which the clkswitch signal controls whether inclk0 or inclk1 is the input clock to the PLL. The characteristics of a manual switchover are similar to the manual override feature in an automatic clock switchover, in which the switchover circuit is edge-sensitive. When the clkswitch signal goes high, the switchover sequence starts. The falling edge of the clkswitch signal does not cause the circuit to switch back to the previous input clock.

• For more information about PLL software support in the Quartus II software, refer to the *ALTPLL Megafunction User Guide*.

Guidelines

Use the following guidelines to design with clock switchover in PLLs:

Clock loss detection and automatic clock switchover require the inclk0 and inclk1 frequencies be within 20% of each other. Failing to meet this requirement causes the clkbad0 and clkbad1 signals to function improperly. Figure 5–22 shows how to adjust PLL counter settings dynamically by shifting their new settings into a serial shift register chain or scan chain. Serial data shifts to the scan chain via the scandataport, and shift registers are clocked by scanclk. The maximum scanclk frequency is 100 MHz. After shifting the last bit of data, asserting the configupdate signal for at least one scanclk clock cycle synchronously updates the PLL configuration bits with the data in the scan registers.





The counter settings are updated synchronously to the clock frequency of the individual counters. Therefore, not all counters update simultaneously.

To reconfigure the PLL counters, perform the following steps:

- 1. The scanclkena signal is asserted at least one scanclk cycle prior to shifting in the first bit of scandata (D0).
- 2. Serial data (scandata) is shifted into the scan chain on the second rising edge of scanclk.
- 3. After all 144 bits have been scanned into the scan chain, the scanclkena signal is de-asserted to prevent inadvertent shifting of bits in the scan chain.
- 4. The configupdate signal is asserted for one scanclk cycle to update the PLL counters with the contents of the scan chain.
- 5. The scandone signal goes high indicating that the PLL is being reconfigured. A falling edge indicates that the PLL counters have been updated with new settings.
- 6. Reset the PLL using the areset signal if you make any changes to the M, N, post-scale output C counters, or the I_{CP}, R, C settings.
- 7. You can repeat steps 1 through 5 to reconfigure the PLL any number of times.

Section II. I/O Interfaces

This section provides information about Cyclone[®] IV device family I/O features and high-speed differential and external memory interfaces.

This section includes the following chapters:

- Chapter 6, I/O Features in Cyclone IV Devices
- Chapter 7, External Memory Interfaces in Cyclone IV Devices

Revision History

Refer to each chapter for its own specific revision history. For information about when each chapter was updated, refer to the Chapter Revision Dates section, which appears in the complete handbook.

Table 6–8 and Table 6–9 summarize the total number of supported row and column differential channels in the Cyclone IV device family.

Table 6–8. Cyclone IV E I/O and Differential Channel Count

Device		EP4CE6			EP4CE10				EDAFE16					EP4CE22			EP4CE30			EDACEAD	Er46640			EP4CE55			EP4CE75		EDAPE116	
Numbers of Differential Channels <i>(1), (2</i>)	144-EQPF	256-UBGA	256-FBGA	144-EQPF	256-UBGA	256-FBGA	144-EQPF	164-MBGA	256-MBGA	256-UBGA	256-FBGA	484-FBGA	144-EQPF	256-UBGA	256-FBGA	324-FBGA	484-FBGA	780-FBGA	324-FBGA	484-UBGA	484-FBGA	780-FBGA	484-UBGA	484-FBGA	780-FBGA	484-UBGA	484-FBGA	780-FBGA	484-FBGA	780-FBGA
User I/O (3)	91	179	179	91	179	179	81	89	165	165	165	343	79	153	153	193	328	532	193	328	328	532	324	324	374	292	292	426	280	528
User I/O Banks	8	8	8	8	8	8	8	8	8	8	8	8	8	8	8	8	8	8	8	8	8	8	8	8	8	8	8	8	8	8
LVDS (4), (6)	8	23	23	8	23	23	6	8	21	21	21	67	7	20	20	30	60	112	30	60	60	112	62	62	70	54	54	79	50	103
Emulated LVDS <i>(5), (</i> <i>6)</i>	13	43	43	13	43	43	12	13	32	32	32	70	10	32	32	38	64	112	38	64	64	112	70	70	90	56	56	99	53	127

Notes to Table 6-8:

(1) User I/O pins are used as inputs or outputs; clock input pins are used as inputs only; clock output pins are used as output only.

(2) For differential pad placement guidelines, refer to "Pad Placement" on page 6-23.

(3) The I/O pin count includes all GPIOs, dedicated clock pins, and dual-purpose configuration pins. Dedicated configuration pins are not included in the pin count.

(4) The true LVDS count includes all LVDS I/O pairs, differential clock input and clock output pins in row I/O banks 1, 2, 5, and 6.

(5) The emulated LVDS count includes all LVDS I/O pairs, differential clock input and clock output pins in column I/O banks 3, 4, 7, and 8.

(6) LVDS input and output buffers are sharing the same p and n pins. One LVDS I/O channel can only be either transmitter or receiver at a time.

The CLKIN/REFCLK pins are powered by dedicated V_{CC_CLKIN3A}, V_{CC_CLKIN3B}, V_{CC_CLKIN3B}, v_{CC_CLKIN8A}, and V_{CC_CLKIN8B} power supplies separately in their respective I/O banks to avoid the different power level requirements in the same bank for GPIO.

				VCC_C	LKIN Level	I/O Pin Type			
I/O Standard HSSI Protocol		Coupling	Termination	Input	Output	Column I/O	Row I/O	Supported I/O Banks	
LVDS	All		Off chip	2.5V	Not supported	Yes	No	3A, 3B, 8A, 8B	
LVPECL	All	Differential AC (Need	Off chip	2.5V	Not supported	Yes	No	3A, 3B, 8A, 8B	
	All	off chip resistor to	Off chip	2.5V	Not supported	Yes	No	3A, 3B, 8A, 8B	
1.2V, 1.5V, 3.3V PCML	All	restore V _{CM})	Off chip	2.5V	Not supported	Yes	No	3A, 3B, 8A, 8B	
	All		Off chip	2.5V	Not supported	Yes	No	3A, 3B, 8A, 8B	
HCSL	PCIe	Differential DC	Off chip	2.5V	Not supported	Yes	No	3A, 3B, 8A, 8B	

Table 6–10. Cyclone IV GX HSSI REFCLK I/O Standard Support Using GPIO CLKIN Pins (1), (2)

Notes to Table 6-10:

(1) The EP4CGX15, EP4CGX22, and EP4CGX30 devices have two pairs of dedicated clock input pins in banks 3A and 8A for HSSI input reference clock. I/O banks 3B and 8B are not available in EP4CGX15, EP4CGX22, and EP4CGX30 devices.

(2) The EP4CGX50, EP4CGX75, EP4CGX110, and EP4CGX150 devices have four pairs of dedicated clock input pins in banks 3A, 3B, 8A, and 8B for HSSI input or single-ended clock input.

To For more information about the AC-coupled termination scheme for the HSSI reference clock, refer to the *Cyclone IV Transceivers Architecture* chapter.

LVDS I/O Standard Support in Cyclone IV Devices

The LVDS I/O standard is a high-speed, low-voltage swing, low power, and GPIO interface standard. Cyclone IV devices meet the ANSI/TIA/EIA-644 standard with the following exceptions:

- The maximum differential output voltage (V_{OD}) is increased to 600 mV. The maximum V_{OD} for ANSI specification is 450 mV.
- The input voltage range is reduced to the range of 1.0 V to 1.6 V, 0.5 V to 1.85 V, or 0 V to 1.8 V based on different frequency ranges. The ANSI/TIA/EIA-644 specification supports an input voltage range of 0 V to 2.4 V.
- For LVDS I/O standard electrical specifications in Cyclone IV devices, refer to the *Cyclone IV Device Datasheet* chapter.

Figure 8–11 shows the recommended balanced star routing for multiple bus master interfaces to minimize signal integrity issues.





Notes to Figure 8-11:

- (1) Altera recommends that *M* does not exceed 6 inches, as listed in Table 8–11 on page 8–28.
- (2) Altera recommends using a balanced star routing. Keep the *N* length equal and as short as possible to minimize reflection noise from the transmission line. The *M* length is applicable for this setup.

Estimating AP Configuration Time

AP configuration time is dominated by the time it takes to transfer data from the parallel flash to Cyclone IV E devices. This parallel interface is clocked by the Cyclone IV E DCLK output (generated from an internal oscillator). The DCLK minimum frequency when using the 40-MHz oscillator is 20 MHz (50 ns). In word-wide cascade programming, the DATA [15..0] bus transfers a 16-bit word and essentially cuts configuration time to approximately 1/16 of the AS configuration time. Equation 8–4 and Equation 8–5 show the configuration time calculations.

Equation 8-4.

Size $\times \left(\frac{\text{maximum DCLK period}}{16 \text{ bits per DCLK cycle}}\right)$ = estimated maximum configuration time

Equation 8-5.

9,600,000 bits ×
$$\left(\frac{50 \text{ ns}}{16 \text{ bit}}\right)$$
 = 30 ms

DCLK, DATA [7..0], and CONF_DONE) are connected to every device in the chain. Configuration signals may require buffering to ensure signal integrity and prevent clock skew problems. Ensure that the DCLK and DATA lines are buffered. All devices initialize and enter user mode at the same time, because all device CONF_DONE pins are tied together.

All nSTATUS and CONF_DONE pins are tied together and if any device detects an error, configuration stops for the entire chain and the entire chain must be reconfigured. For example, if the first device flags an error on nSTATUS, it resets the chain by pulling its nSTATUS pin low. This behavior is similar to a single device detecting an error.

Figure 8–21 shows multi-device FPP configuration when both Cyclone IV devices are receiving the same configuration data. Configuration pins (nCONFIG, nSTATUS, DCLK, DATA[7..0], and CONF_DONE) are connected to every device in the chain. Configuration signals may require buffering to ensure signal integrity and prevent clock skew problems. Ensure that the DCLK and DATA lines are buffered. Devices must be of the same density and package. All devices start and complete configuration at the same time.

Figure 8–21. Multi-Device FPP Configuration Using an External Host When Both Devices Receive the Same Data



Notes to Figure 8-21:

- (1) You must connect the pull-up resistor to a supply that provides an acceptable input signal for all devices in the chain. V_{CC} must be high enough to meet the V_{IH} specification of the I/O on the device and the external host.
- (2) The nCEO pins of both devices are left unconnected or used as user I/O pins when configuring the same configuration data into multiple devices.
- (3) The MSEL pin settings vary for different configuration voltage standards and POR time. To connect the MSEL pins, refer to Table 8–4 on page 8–8 and Table 8–5 on page 8–9. Connect the MSEL pins directly to V_{CCA} or GND.
- (4) All I/O inputs must maintain a maximum AC voltage of 4.1 V. DATA [7..0] and DCLK must fit the maximum overshoot outlined in Equation 8–1 on page 8–5.

You can use a single configuration chain to configure Cyclone IV devices with other Altera devices that support FPP configuration. To ensure that all devices in the chain complete configuration at the same time or that an error flagged by one device starts reconfiguration in all devices, tie all the CONF DONE and nSTATUS pins together.

• For more information about configuring multiple Altera devices in the same configuration chain, refer to *Configuring Mixed Altera FPGA Chains* in volume 2 of the *Configuration Handbook*.

■ In AP configuration scheme, the only way to re-engage the AP controller is to issue the ACTIVE_ENGAGE instruction. In this case, asserting the nCONFIG pin does not re-engage either active controller.

ACTIVE_ENGAGE

The ACTIVE_ENGAGE instruction allows you to re-engage a disengaged active controller. You can issue this instruction any time during configuration or user mode to reengage an already disengaged active controller, as well as trigger reconfiguration of the Cyclone IV device in the active configuration scheme.

The ACTIVE_ENGAGE instruction functions as the PULSE_NCONFIG instruction when the device is in the PS or FPP configuration schemes. The nCONFIG pin is disabled when the ACTIVE_ENGAGE instruction is issued.

Altera does not recommend using the ACTIVE_ENGAGE instruction, but it is provided as a fail-safe instruction for re-engaging the active configuration controller (AS and AP).

Overriding the Internal Oscillator

This feature allows you to override the internal oscillator during the active configuration scheme. The AS and AP configuration controllers use the internal oscillator as the clock source. You can change the clock source to CLKUSR through the JTAG instruction.

The EN_ACTIVE_CLK and DIS_ACTIVE_CLK JTAG instructions toggle on or off whether or not the active clock is sourced from the CLKUSR pin or the internal configuration oscillator. To source the active clock from the CLKUSR pin, issue the EN_ACTIVE_CLK instruction. This causes the CLKUSR pin to become the active clock source. When using the EN_ACTIVE_CLK instruction, you must enable the internal oscillator for the clock change to occur. By default, the configuration oscillator is disabled after configuration and initialization is complete as well as the device has entered user mode.

However, the internal oscillator is enabled in user mode by any of the following conditions:

- A reconfiguration event (for example, driving the nCONFIG pin to go low)
- Remote update is enabled
- Error detection is enabled
- When using the EN_ACTIVE_CLK and DIS_ACTIVE_CLK JTAG instructions to override the internal oscillator, you must clock the CLKUSR pin at two times the expected DCLK frequency. The CLKUSR pin allows a maximum frequency of 40 MHz (40 MHz DCLK).

Normally, a test instrument uses the CLKUSR pin when it wants to drive its own clock to control the AS state machine.

To revert the clock source back to the configuration oscillator, issue the DIS_ACTIVE_CLK instruction. After you issue the DIS_ACTIVE_CLK instruction, you must continue to clock the CLKUSR pin for 10 clock cycles. Otherwise, even toggling the nCONFIG pin does not revert the clock source and reconfiguration does not occur. A POR reverts the clock source back to the configuration oscillator. Toggling the nCONFIG pin or driving the JTAG state machine to reset state does not revert the clock source.

Pin Name	User Mode	Configuration Scheme	Pin Type	Description
CONF_DONE	N/A	All	Bidirectional open-drain	 Status output—the target Cyclone IV device drives the CONF_DONE pin low before and during configuration. After all the configuration data is received without error and the initialization cycle starts, the target device releases CONF_DONE. Status input—after all the data is received and CONF_DONE goes high, the target device initializes and enters user mode. The CONF_DONE pin must have an
				external 10-kΩ pull-up resistor in order for the device to initialize. Driving CONF_DONE low after configuration and initialization does not affect the configured device. Do not connect hus
				holds or ADC to CONF_DONE pin.
nCE	N/A	All	Input	Active-low chip enable. The nCE pin activates the Cyclone IV device with a low signal to allow configuration. You must hold nCE pin low during configuration, initialization, and user-mode. In a single-device configuration, you must tie the nCE pin low. In a multi-device configuration, nCE of the first device is tied low while its nCEO pin is connected to nCE of the next device in the chain. You must hold the nCE pin low for successful JTAG programming of the device.
	N/A if		Output open-drain	Output that drives low when configuration is complete. In a single-device configuration, you can leave this pin floating or use it as a user I/O pin after configuration. In a multi-device configuration, this pin feeds the nCE pin of the next device. The $nCEO$ of the last device in the chain is left floating or used as a user I/O pin after configuration.
nCEO	I/O if option is off.	All		If you use the nCEO pin to feed the nCE pin of the next device, use an external 10-k Ω pull-up resistor to pull the nCEO pin high to the V _{CCIO} voltage of its I/O bank to help the internal weak pull-up resistor.
				If you use the nCEO pin as a user I/O pin after configuration, set the state of the pin on the Dual-Purpose Pin settings.
nCSO,				Output control signal from the Cyclone IV device to the serial configuration device in AS mode that enables the configuration device. This pin functions as nCSO in AS mode and FLASH_nCE in AP mode.
FLASH_nCE (1)	Ι/Ο	AS, AP (2)	Output	Output control signal from the Cyclone IV device to the parallel flash in AP mode that enables the flash. Connects to the $CE\#$ pin on the Micron P30 or P33 flash. ⁽²⁾
				This pin has an internal pull-up resistor that is always active.

Table 8-20	. Dedicated	Configuration	Pins on th	ne Cyclone	IV Device	(Part 2 of 4)
------------	-------------	---------------	------------	------------	-----------	---------------



Figure 1–32. Clock Distribution in Non-Bonded Channel Configuration for Transceivers in F484 and Larger Packages

Notes to Figure 1-32:

- (1) High-speed clock.
- (2) Low-speed clock.
- (3) These PLLs have restricted clock driving capability and may not reach all connected channels. For details, refer to Table 1–9.

The transceiver datapath clocking varies in non-bonded channel configuration depending on the PCS configuration.

Figure 1–33 shows the datapath clocking in transmitter only operation. In this mode, each channel selects the high- and low-speed clock from one of the supported PLLs. The high-speed clock feeds to the serializer for parallel to serial operation. The low-speed clock feeds to the following blocks in the transmitter PCS:

- 8B/10B encoder
- read clock of the byte serializer
- read clock of the TX phase compensation FIFO

Clock Name	Clock Description	Interface Direction				
cal_blk_clk ⁽²⁾	Transceiver calibration block clock	FPGA fabric to transceiver				

Table 1–11. FPGA Fabric-Transceiver Interface Clocks (Part 2 of 2)

Notes to Table 1-11:

(1) Offset cancellation process that is executed after power cycle requires reconfig_clk clock. The reconfig_clk must be driven with a free-running clock and not derived from the transceiver blocks.

(2) For the supported clock frequency range, refer to the *Cyclone IV Device Data Sheet*.

In the transmitter datapath, TX phase compensation FIFO forms the FPGA fabric-transmitter interface. Data and control signals for the transmitter are clocked with the FIFO write clock. The FIFO write clock supports automatic clock selection by the Quartus II software (depending on channel configuration), or user-specified clock from tx_coreclk port. Table 1–12 details the automatic TX phase compensation FIFO write clock selection by the Quartus II software.

The Quartus II software assumes automatic clock selection for TX phase compensation FIFO write clock if you do not enable the tx_coreclk port.

Table 1–12. Automatic TX Phase Compensation FIFO Write Clock Selection

Channel Configuration	Quartus II Selection
Non-bonded	tx_clkout clock feeds the FIFO write clock. tx_clkout is forwarded through the transmitter channel from low-speed clock, which also feeds the FIFO read clock.
Bonded	coreclkout clock feeds the FIFO write clock for the bonded channels. coreclkout clock is the common bonded low-speed clock, which also feeds the FIFO read clock in the bonded channels.

When using user-specified clock option, ensure that the clock feeding tx_coreclk port has 0 ppm difference with the TX phase compensation FIFO read clock.

In the receiver datapath, RX phase compensation FIFO forms the receiver-FPGA fabric interface. Data and status signals from the receiver are clocked with the FIFO read clock. The FIFO read clock supports automatic clock selection by the Quartus II software (depending on channel configuration), or user-specified clock from rx_coreclk port. Table 1–13 details the automatic RX phase compensation FIFO read clock selection by the Quartus II software.

The Quartus II software assumes automatic clock selection for RX phase compensation FIFO read clock if you do not enable the rx_coreclk port.

Table 1–13.	Automatic RX Ph	se Compensatio	n FIFO Read	Clock Selection	(Part 1 of 2)
-------------	-----------------	----------------	-------------	------------------------	---------------

Channel Configuration		Quartus II Selection
Non bonded	With rate match FIFO ⁽¹⁾	tx_clkout clock feeds the FIFO read clock. tx_clkout is forwarded through the receiver channel from low-speed clock, which also feeds the FIFO write clock and transmitter PCS.
Non-bonded	Without rate match FIFO	$\tt rx_clkout$ clock feeds the FIFO read clock. $\tt rx_clkout$ is forwarded through the receiver channel from low-speed recovered clock, which also feeds the FIFO write clock.

Figure 1–59 shows an example of rate match FIFO insertion in the case where one symbol must be inserted. Because the rate match FIFO can only insert /I2/ ordered sets, it inserts one /I2/ ordered set (two symbols inserted).

Figure 1–59. Example of Rate Match FIFO Insertion in GIGE Mode



The rate match FIFO does not insert or delete code groups automatically to overcome FIFO empty or full conditions. In this case, the rate match FIFO asserts the rx_rmfifofull and rx_rmfifoempty flags for at least two recovered clock cycles to indicate rate match FIFO full and empty conditions, respectively. You must then assert the rx_digitalreset signal to reset the receiver PCS blocks.

Serial RapidIO Mode

Serial RapidIO mode provides the non-bonded (×1) transceiver channel datapath configuration for SRIO protocol implementation. The Cyclone IV GX transceiver provides the PMA and the following PCS functions:

- 8B/10B encoding and decoding
- lane synchronization state machine

Cyclone IV GX transceivers do not have built-in support for some PCS functions such as pseudo-random idle sequence generation and lane alignment in ×4 bonded channel configuration. If required, you must implement these functions in a user logics or external circuits.

The RapidIO Trade Association defines a high-performance, packet-switched interconnect standard to pass data and control information between microprocessors, digital signals, communications, network processes, system memories, and peripheral devices. The SRIO physical layer specification defines serial protocol running at 1.25 Gbps, 2.5 Gbps, and 3.125 Gbps in either single-lane (×1) or bonded four-lane (×4) at each line rate. Cyclone IV GX transceivers support single-lane (×1) configuration at all three line rates. Four ×1 channels configured in Serial RapidIO mode can be instantiated to achieve one non-bonded ×4 SRIO link. When implementing four ×1 SRIO channels, the receivers do not have lane alignment or deskew capability.

Receive Bit-Slip Indication

The number of bits slipped in the word aligner for synchronization in manual alignment mode is provided with the rx_bitslipboundaryselectout [4..0] signal. For example, if one bit is slipped in word aligner to achieve synchronization, the output on rx_bitslipboundaryselectout [4..0] signal shows a value of 1 (5'00001). The information from this signal helps in latency calculation through the receiver as the number of bits slipped in the word aligner varies at each synchronization.

Transmit Bit-Slip Control

The transmitter datapath supports bit-slip control to delay the serial data transmission by a number of specified bits in PCS with tx_bitslipboundaryselect[4..0] port. With 8- or 10-bit channel width, the transmitter supports zero to nine bits of data slip. This feature helps to maintain a fixed round trip latency by compensating latency variation from word aligner when providing the appropriate values on tx_bitslipboundaryselect[4..0] port based on values on rx_bitslipboundaryselectout[4..0] signal.

PLL PFD feedback

In Deterministic Latency mode, when transmitter input reference clock frequency is the same as the low-speed clock, the PLL that clocks the transceiver supports PFD feedback. When enabled, the PLL compensates for delay uncertainty in the low-speed clock (tx_clkout in ×1 configuration or coreclkout in ×4 configuration) path relative to input reference and the transmitter datapath latency is fixed relative to the transmitter input reference clock.

SDI Mode

SDI mode provides the non-bonded (×1) transceiver channel datapath configuration for HD- and 3G-SDI protocol implementations.

Cyclone IV GX transceivers configured in SDI mode provides the serialization and deserialization functions that supports the SDI data rates as listed in Table 1–24.

SMPTE Standard ⁽¹⁾	Configuration	Data Rate (Mbps)	FPGA Fabric-to- Transceiver Width	Byte SERDES Usage	
20214		1/92 5	20-bit	Used	
	High definition (HD)	1405.5	10-bit	Not used	
292101		1/85	20-bit	Used	
		1405	10-bit	Not used	
42414	Third-generation (3G)	2967	20-hit	haall	
424101	minu-generation (50)	2970	20-011	USEU	

Table 1–24. Supported SDI Data Rates

Note to Table 1-24:

(1) Society of Motion Picture and Television Engineers (SMPTE).

SDI functions such as scrambling/de-scrambling, framing, and cyclic redundancy check (CRC) must be implemented in the user logic.

Block	Port Name	Input/ Output	Clock Domain	Description			
				Transceiver block power down.			
	gxb_powerdown	Input	Asynchronous signal	 When asserted, all digital and analog circuitry in the PCS, HSSI, CDR, and PCIe modules are powered down. 			
				 Asserting the gxb_powerdown signal does not power down the refclk buffers. 			
			Asynchronous signal.	Transmitter PCS reset			
Reset & Power Down	tx_digitalreset	Input	width is two parallel clock cycles.	 When asserted, the transmitter PCS blocks are reset. 			
			Asynchronous signal.	Receiver PMA reset.			
	rx_analogreset	Input	The minimum pulse width is two parallel clock cycles.	 When asserted, analog circuitry in the receiver PMA block is reset. 			
			Asynchronous signal.	Dessiver DCC reset			
	rx_digitalreset	Input	The minimum pulse width is two parallel clock cycles.	 Receiver PCS reset. When asserted, the receiver PCS blocks are reset. 			
				Dynamic reconfiguration clock.			
	reconfig clk	Innut	Clock signal	 Also used for offset cancellation except in PIPE mode. 			
Reconfiguration	recomg_ow	mput	olock signal	 For the supported frequency range for this clock, refer to the Cyclone IV Device Data Sheet chapter. 			
	reconfig_togxb	Input	Asynchronous signal	From the dynamic reconfiguration controller.			
	reconfig_fromgxb	Output	Asynchronous signal	To the dynamic reconfiguration controller.			
Calibration Block	cal_blk_clk	Input	Clock signal	Clock for the transceiver calibration block.			
Calibration Diock	cal_blk_powerdown	Input	Asynchronous signal	Calibration block power down control.			
				BIST or PRBS test completion indicator.			
	rx_bistdone	Output	Asynchronous signal	 A high level during BIST test mode indicates the verifier either receives complete pattern cycle or detects an error and stays asserted until being reset using the rx_digitalreset port. 			
Test Mode				 A high level during PRBS test mode indicates the verifier receives complete pattern cycle and stays asserted until being reset using the rx_digitalreset port. 			
				BIST or PRBS verifier error indicator			
	rx_bisterr	Output	Asynchronous signal	 In BIST test mode, the signal stays asserted upon detecting an error until being reset using the rx_digitalreset port. 			
				 In PRBS test mode, the signal asserts for a minimum of 3 rx_clkout clock cycles upon detecting an error and deasserts if the following PRBS sequence contains no error. 			

Table 1–29. Multipurpose PLL, General Purpose PLL and Miscellaneous Ports in ALTGX Megafunction for Cyclone IV GX (Part 2 of 2)

User Reset and Power-Down Signals

Each transceiver channel in the Cyclone IV GX device has individual reset signals to reset its physical coding sublayer (PCS) and physical medium attachment (PMA). The transceiver block also has a power-down signal that affects the multipurpose phase-locked loops (PLLs), general purpose PLLs, and all the channels in the transceiver block.



Table 2–1 lists the reset signals available for each transceiver channel.

Signal	ALTGX MegaWizard Plug-In Manager Configurations	Description
ty digitalreset (1)	 Transmitter Only Receiver and Transmitter 	Provides asynchronous reset to all digital logic in the transmitter PCS, including the XAUI transmit state machine.
en_argrourrobot		The minimum pulse width for this signal is two parallel clock cycles.
rx_digitalreset ⁽¹⁾	 Receiver Only Receiver and Transmitter 	 Resets all digital logic in the receiver PCS, including: XAUI receiver state machines GIGE receiver state machines XAUI channel alignment state machine BIST-PRBS verifier BIST-incremental verifier The minimum pulse width for this signal is two parallel clock evologies
rx_analogreset	 Receiver Only Receiver and Transmitter 	Resets the receiver CDR present in the receiver channel. The minimum pulse width is two parallel clock cycles.

Table 2–1. Transceiver Channel Reset Signals

Note to Table 2–1:

(1) Assert this signal until the clocks coming out of the multipurpose PLL and receiver CDR are stabilized. Stable parallel clocks are essential for proper operation of transmitter and receiver phase-compensation FIFOs in the PCS.

As shown in Figure 2–5, perform the following reset procedure for the receiver CDR in manual lock mode configuration:

- 1. After power up, assert pll areset for a minimum period of 1 µs (the time between markers 1 and 2).
- 2. Keep the tx digitalreset, rx analogreset, rx digitalreset, and rx locktorefclk signals asserted and the rx locktodata signal deasserted during this time period. After you deassert the pll areset signal, the multipurpose PLL starts locking to the input reference clock.
- 3. After the multipurpose PLL locks, as indicated by the pll locked signal going high (marker 3), deassert the tx digitalreset signal (marker 4). For the receiver operation, after deassertion of the busy signal, wait for two parallel clock cycles to deassert the rx_analogreset signal.
- 4. In a bonded channel group, wait for at least $t_{LTR_LTD_Manual}$, then deassert rx locktorefclk and assert rx locktodata (marker 7). At this point, the receiver CDR of all the channels enters into lock-to-data mode and starts locking to the received data.
- 5. After asserting the rx locktodata signal, wait for at least t_{LTD Manual} before deasserting rx_digitalreset (the time between markers 7 and 8). At this point, the transmitter and receiver are ready for data traffic.

Non-Bonded Channel Configuration

In non-bonded channels, each channel in the ALTGX MegaWizard Plug-In Manager instance contains its own tx digitalreset, rx analogreset, rx digitalreset, and rx freqlocked signals.

You can reset each channel independently. For example, if there are four non-bonded channels, the ALTGX MegaWizard Plug-In Manager provides four each of the following signals: tx digitalreset, rx analogreset, rx digitalreset, and rx freqlocked.

Table 2–6 lists the reset and power-down sequences for one channel in a non-bonded configuration under the stated functional modes.

Table 2–6. Reset and Power-Down Sequences for Non-Bonded Channel Configurations								
Channel Set Up	Receiver CDR Mode	Refer to						
Transmitter Only	Basic ×1	"Transmitter Only Channel" on page 2–11						
Receiver Only	Automatic lock mode	"Receiver Only Channel—Receiver CDR in Automatic Lock Mode" on page 2–11						
Receiver Only	Manual lock mode	"Receiver Only Channel—Receiver CDR in Manual Lock Mode" on page 2–12						
Receiver and Transmitter	Automatic lock mode	"Receiver and Transmitter Channel—Receiver CDR in Automatic Lock Mode" on page 2–13						
Receiver and Transmitter	Manual lock mode	"Receiver and Transmitter Channel—Receiver CDR in						

Follow the same reset sequence for all the other channels in the non-bonded configuration.

Manual Lock Mode" on page 2-14

Clocking/Interface Options

The following describes the **Clocking/Interface** options available in Cyclone IV GX devices. The core clocking setup describes the transceiver core clocks that are the write and read clocks of the Transmit Phase Compensation FIFO and the Receive Phase Compensation FIFO, respectively. Core clocking is classified as transmitter core clocking and receiver core clocking.

Table 3–6 lists the supported clocking interface settings for channel reconfiguration mode in Cyclone IV GX devices.

ALTGX Setting	Description						
Dynamic Reconfiguration Channel Internal and Interface Settings							
	Select one of the available options:						
How should the receivers be clocked?	Share a single transmitter core clock between receivers						
	 Use the respective channel transmitter core clocks 						
	 Use the respective channel receiver core clocks 						
How should the transmitters be clocked?	Select one of the available options:						
	Share a single transmitter core clock between transmitters						
	 Use the respective channel transmitter core clocks 						

 Table 3–6. Dynamic Reconfiguration Clocking Interface Settings in Channel Reconfiguration

 Mode

Transmitter core clocking refers to the clock that is used to write the parallel data from the FPGA fabric into the Transmit Phase Compensation FIFO. You can use one of the following clocks to write into the Transmit Phase Compensation FIFO:

- tx_coreclk—you can use a clock of the same frequency as tx_clkout from the FPGA fabric to provide the write clock to the Transmit Phase Compensation FIFO. If you use tx_coreclk, it overrides the tx_clkout options in the ALTGX MegaWizard Plug-In Manager.
- tx_clkout—the Quartus II software automatically routes tx_clkout to the FPGA fabric and back into the Transmit Phase Compensation FIFO.

Functional Simulation of the Dynamic Reconfiguration Process

This section describes the points to be considered during functional simulation of the dynamic reconfiguration process.

- You must connect the ALTGX_RECONFIG instance to the ALTGX_instance/ALTGX instances in your design for functional simulation.
- The functional simulation uses a reduced timing model of the dynamic reconfiguration controller. The duration of the offset cancellation process is 16 reconfig_clk clock cycles for functional simulation only.
- The gxb_powerdown signal must not be asserted during the offset cancellation sequence (for functional simulation and silicon).

Document Revision History

Table 3–8 lists the revision history for this chapter.

 Table 3–8.
 Document Revision History

Date	Version	Changes
November 2011	2.1	 Updated "Dynamic Reconfiguration Controller Architecture", "PMA Controls Reconfiguration Mode", "PLL Reconfiguration Mode", and "Error Indication During Dynamic Reconfiguration" sections.
		■ Updated Table 3–2 and Table 3–4.
December 2010		 Updated for the Quartus II software version 10.1 release.
	2.0	■ Updated Table 3–1, Table 3–2, Table 3–3, Table 3–4, Table 3–5, and Table 3–6.
		■ Added Table 3–7.
		■ Updated Figure 3–1, Figure 3–11, Figure 3–13, and Figure 3–14.
		 Updated "Offset Cancellation Feature", "Error Indication During Dynamic Reconfiguration", "Data Rate Reconfiguration Mode Using RX Local Divider", "PMA Controls Reconfiguration Mode", and "Control and Status Signals for Channel Reconfiguration" sections.
July 2010	1.0	Initial release.

DC Characteristics

This section lists the I/O leakage current, pin capacitance, on-chip termination (OCT) tolerance, and bus hold specifications for Cyclone IV devices.

Supply Current

The device supply current requirement is the minimum current drawn from the power supply pins that can be used as a reference for power size planning. Use the Excel-based early power estimator (EPE) to get the supply current estimates for your design because these currents vary greatly with the resources used. Table 1–6 lists the I/O pin leakage current for Cyclone IV devices.

Table 1–6. I/O Pin Leakage Current for Cyclone IV Devices (1), (2)

Symbol	Parameter	Conditions	Device	Min	Тур	Max	Unit
I _I	Input pin leakage current	$V_{I} = 0 V \text{ to } V_{CCIOMAX}$	_	-10		10	μA
I _{OZ}	Tristated I/O pin leakage current	$V_0 = 0 V \text{ to } V_{\text{CCIOMAX}}$		-10		10	μA

Notes to Table 1-6:

(1) This value is specified for normal device operation. The value varies during device power-up. This applies for all V_{CCI0} settings (3.3, 3.0, 2.5, 1.8, 1.5, and 1.2 V).

(2) The 10 μ A I/O leakage current limit is applicable when the internal clamping diode is off. A higher current can be observed when the diode is on.

Bus Hold

The bus hold retains the last valid logic state after the source driving it either enters the high impedance state or is removed. Each I/O pin has an option to enable bus hold in user mode. Bus hold is always disabled in configuration mode.

Table 1–7 lists bus hold specifications for Cyclone IV devices.

 Table 1–7. Bus Hold Parameter for Cyclone IV Devices (Part 1 of 2)⁽¹⁾

		V _{CC10} (V)												
Parameter	Condition	1.2		1.5		1.8		2.5		3.0		3.3		Unit
		Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	
Bus hold low, sustaining current	V _{IN} > V _{IL} (maximum)	8	_	12	_	30	_	50	_	70	_	70	_	μΑ
Bus hold high, sustaining current	V _{IN} < V _{IL} (minimum)	-8	_	-12	_	-30	_	-50	_	-70	_	-70	_	μΑ
Bus hold low, overdrive current	$0 V < V_{IN} < V_{CCIO}$		125	_	175	_	200	_	300	_	500	_	500	μA
Bus hold high, overdrive current	$0 \text{ V} < \text{V}_{\text{IN}} < \text{V}_{\text{CCIO}}$		-125		-175		-200		-300		-500		-500	μA